

47 CFR PART 15B

TEST REPORT

of

Mobile Phone

Trade Name: Gtran
Brand Name: Gtran
Model Name: W200
Report No.: SZ09110031E01
FCC ID.: X2EW200

prepared for

Wittis Interntaional Communication Ltd

Flat A-B, 11/F, Wah Lik Industrial Centre, 459-469 Castle Peak Road Tsuen Wan, Kowloon, Hong Kong

Shenzhen Electronic Product Quality Testing Center

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Bluetooth® **CTIA** Authorized Test Lab

LAB CODE 20081223-00

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TABLE OF CONTENTS

1.	TEST RESULT CERTIFICATION	3
2.	GENERAL INFORMATION	4
2.1	Equipment under Test (EUT) Description.....	4
2.2	Test Standards and Results.....	5
2.3	Facilities and Accreditations	6
2.3.1	Facilities	6
2.3.2	Test Equipments	6
2.3.3	Test Environment Conditions	7
3.	47 CFR PART 15B REQUIREMENTS	8
3.1	General Information	8
3.1.1	Test Mode	8
3.1.2	Test Setup	9
3.2	Conducted Emission.....	11
3.2.1	Requirement	11
3.2.2	Test Procedure	11
3.2.3	Test Result	12
3.3	Radiated Emission.....	14
3.3.1	Requirement	14
3.3.2	Test Procedure	14
3.3.3	Test Result	15

Change History		
Issue	Date	Reason for change
1.0	December 17, 2009	First edition

1. Test Result Certification

Equipment under Test: Mobile Phone

Trade Name: Gtran

Brand Name: Gtran

Model Name: W200

FCC ID: X2EW200

Applicant: Wittis Interntaional Communication Ltd

Flat A-B, 11/F, Wah Lik Industrial Centre, 459-469 Castle Peak Road

Tsuen Wan, Kowloon, Hong Kong

Manufacturer: Wittis Interntaional Communication Ltd

Flat A-B, 11/F, Wah Lik Industrial Centre, 459-469 Castle Peak Road

Tsuen Wan, Kowloon, Hong Kong

Emission Designator: 1M25F9W

Test Standards: 47 CFR Part 2

47 CFR Part 15 Subpart B

Test date: December 09, 2008 - December 13, 2009

Test Result: PASS

* We Hereby Certify That:

The equipment under test was tested by Shenzhen Morlab Communications Technology Co., Ltd. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by: Mo Huina Dated: 2009.12.18
Mo Huina

Reviewed by: David Deng Dated: 2009.12.18
Deng Jiankun

Approved by: Shu Luan Dated: 2009.12.18
Shu Luan



2. General Information

2.1 Equipment under Test (EUT) Description

Description: Mobile Phone
Model Name: W200
Serial No.....: (n.a, marked #1 by test site)
MEID.....: (n.a)
Hardware Version: 3.0
Software Version: 1.7.20
Modulation: CDMA 1X
Frequency: Tx: 824.7 – 848.31 MHz; Rx: 869.7-893.31MHz
Power Supply: : Battery
Brand name: Gtran
Model Name: GX-002
Capacitance: 800mAh
Rated voltage: 3.7V
Charge limited: 4.2V
Manufacturer: Shenzhen B&K Rechargeable Battery, Inc
Accessory Equipment: AC Adapter (Charger for Battery)
Brand Name: Gtran
Model Name: PPT-P887
Rated Input: ~ 220V, 50Hz
Rated Output: = 5.0V, 500mA
Manufacturer: Shenzhen Putiantong Cyber Industry Co., Ltd
Manufacturer Address: 2F, 5 Building, 43 Industry Area, Baoan District, Shenzhen, China

NOTE:

1. The EUT is a model of CDMA 1X mobile station operating in Cellular band.
2. The EUT can be configured with a TF-Card, and can be used as a mass storage device.
3. The normal configuration for the EUT is the Mobile Phone (MS) associated with ancillary equipments e.g. the Battery and/or the AC Adapter (Charger).
4. For detailed features about the EUT, please see user manual supplied by the applicant.

2.2 Test Standards and Results

The objective of the report is to perform tests according to 47 CFR Part 2, Part 15 Part 22 for FCC ID Certification:

No.	Identity	Document Title
1	47 CFR Part 2 (10-1-05 Edition)	Frequency Allocations and Radio Treaty Matters; General Rules and Regulations
2	47 CFR Part 15 (10-1-05 Edition)	Radio Frequency Devices

Test detailed items and the results are as below:

No.	Rules	Test Type	Result
FCC Part 15 Requirement			
1	§15.107	Conducted Emissions	PASS
2	§15.109	Radiated Emissions	PASS

NOTE:

The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.

2.3 Facilities and Accreditations

2.3.1 Facilities

Shenzhen Electronic Product Quality Testing Center Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is CNAS L1659.

All measurement facilities used to collect the measurement data are located at Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, P. R. China. The site was constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22, the FCC registration number is 741109.

2.3.2 Test Equipments

No.	Description	Specification
1	System Simulator	Manufacturer: Rohde&Schwarz Model No.: CMU200 Serial No.: 100448
2	System Simulator	Manufacturer: Agilent Model No.: E5515C Serial No.: GB43130131
3	Spectrum Analyzer	Manufacturer: Agilent Model No.: E7405A Serial No.: US44210471
4	Telecommunication Antenna	Manufacturer: European Antennas Model No.: PSA-45010R/356 Serial No.: 403688-001
5	Trilogy Antenna	Manufacturer: Schwarzbeck Model No.: VULB 9163 Serial No.: 9163-274
6	Horn Antenna	Manufacturer: Schwarzbeck Model No.: BBHA 9120C Serial No.: 9120C-384
7	Power Splitter	Manufacturer: WEINSCHEL Model No.: 1506A Serial No.: NW521
8	Anechoic Chamber	Manufacturer: Albatross Projects GmbH
9	DC Power Supply	Manufacturer: Good Will Instrument Co., Ltd.
10	Temperature Chamber	Manufacturer: Chongqing YinHe Experimental Equip. Co., Ltd.

NOTE:

1. Equipments listed above have been calibrated and are in the period of validation.

2.3.3 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature:	20 - 25°C
Relative Humidity:	40 - 60%
Atmospheric Pressure:	86-106kPa

3. 47 CFR Part 15B Requirements

3.1 General Information

3.1.1 Test Mode

The test modes of the EUT are showed as below:

(1) Call Mode:

The EUT configuration of the emission tests was MS + Battery + Charger +Headset.

Before the measurement, the lithium battery was completely discharge.

During the measurement, the lithium battery was installed into the MS, and the charger was connected to the MS. A communication link was established between the MS and a System Simulator (SS).

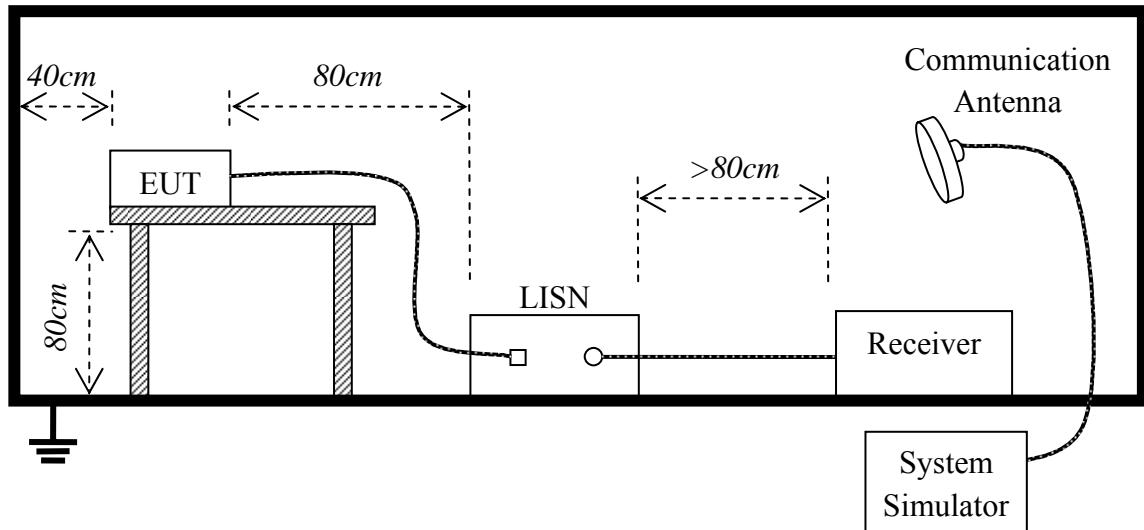
(2) USB Test Mode

The EUT configuration of the emission tests is TransFlash Card + EUT + Battery + PC.

In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a special USB cable supplied by applicant. During the measurement, a communication link was established between the EUT and a System Simulator (SS), simultaneity, the date is transmitting between the PC and the TransFlash Card of the EUT.

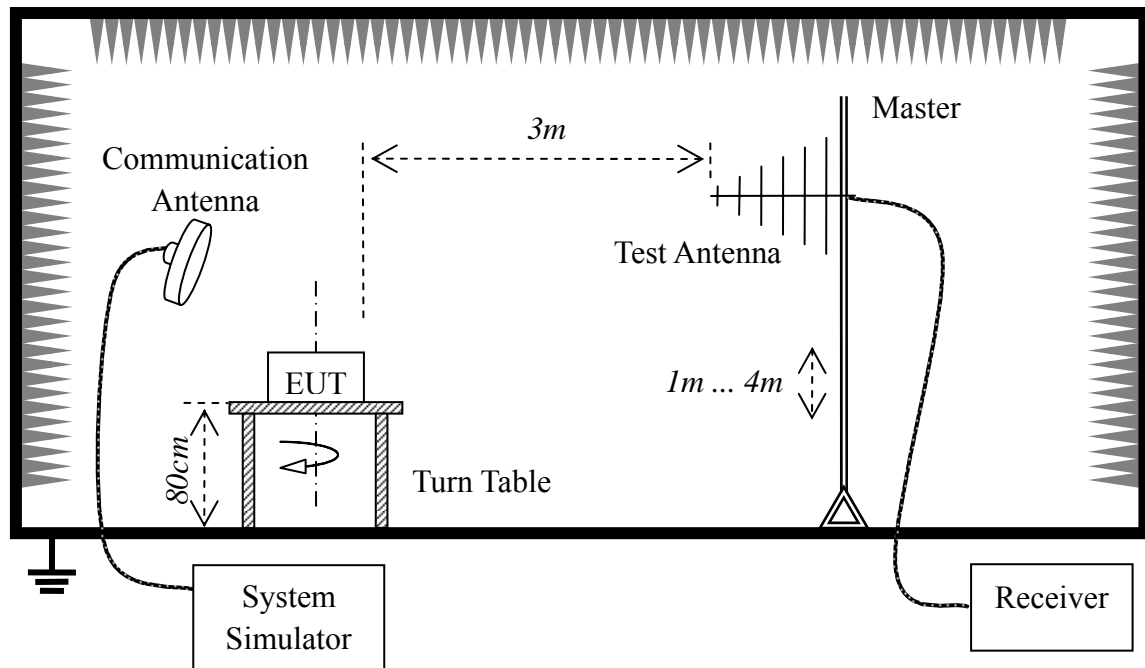
3.1.2 Test Setup

3.1.2.1 Conducted Emission Test



1. The test is performed in a Shield Room; the factors of the test system are calibrated to correct the reading.
2. The EUT is placed on a 0.8 meters high insulating table and keeps 0.4 meters away from the conducting wall of the Shield Room.
3. The EUT is connected to the power mains through a Line Impedance Stabilization Network (LISN). The LISN provides 50Ω/50μH of coupling impedance for the measuring instrument.

3.1.2.2 Radiated Emission Test



1. The test is performed in a Semi-anechoic Chamber; the factors of the test system are calibrated to correct the reading.
2. The EUT is placed on a 0.8 meters high insulating table and keeps 3 meters away from the Test Antenna, which is mounted on the top of a variable-height antenna Master tower.

NOTE:

1. The test method is the substitution method according to TIA-603-C.

3.2 Conducted Emission

3.2.1 Requirement

According to FCC §15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

1. The limit subjects to the Class B digital device.
2. The lower limit shall apply at the band edges.
3. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

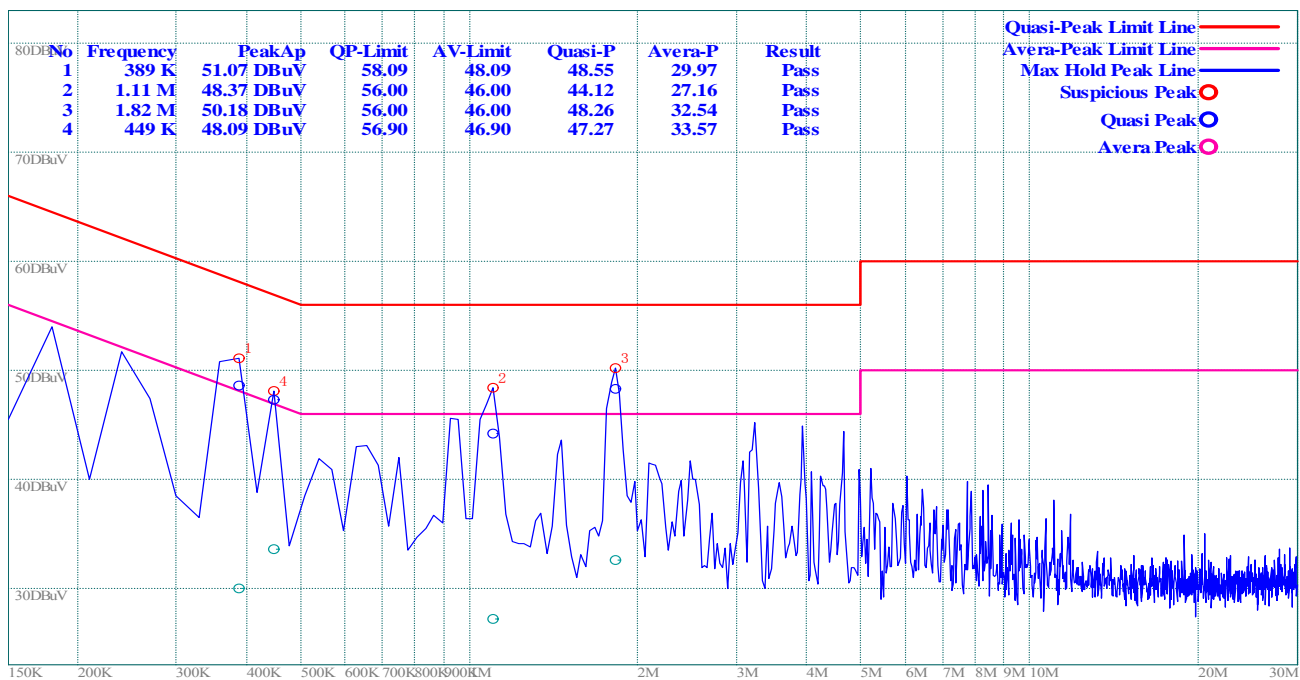
3.2.2 Test Procedure

1. Perform test setup as described in section 3.1.2.1.
2. Each test mode in section 3.1.1 should be applied. At each test mode, the frequency range from 150 kHz to 30MHz is searched using the CISPR Quasi-Peak and/or the Average detector of the Receiver. If the emission levels measured with Quasi-Peak detector are lower than the Average Limit, it's not necessary to measure with Average detector.
3. The emission levels at both L phase and N phase should be tested.
4. Record the test result plot and distinct points.
5. In the test report show the worst test data.

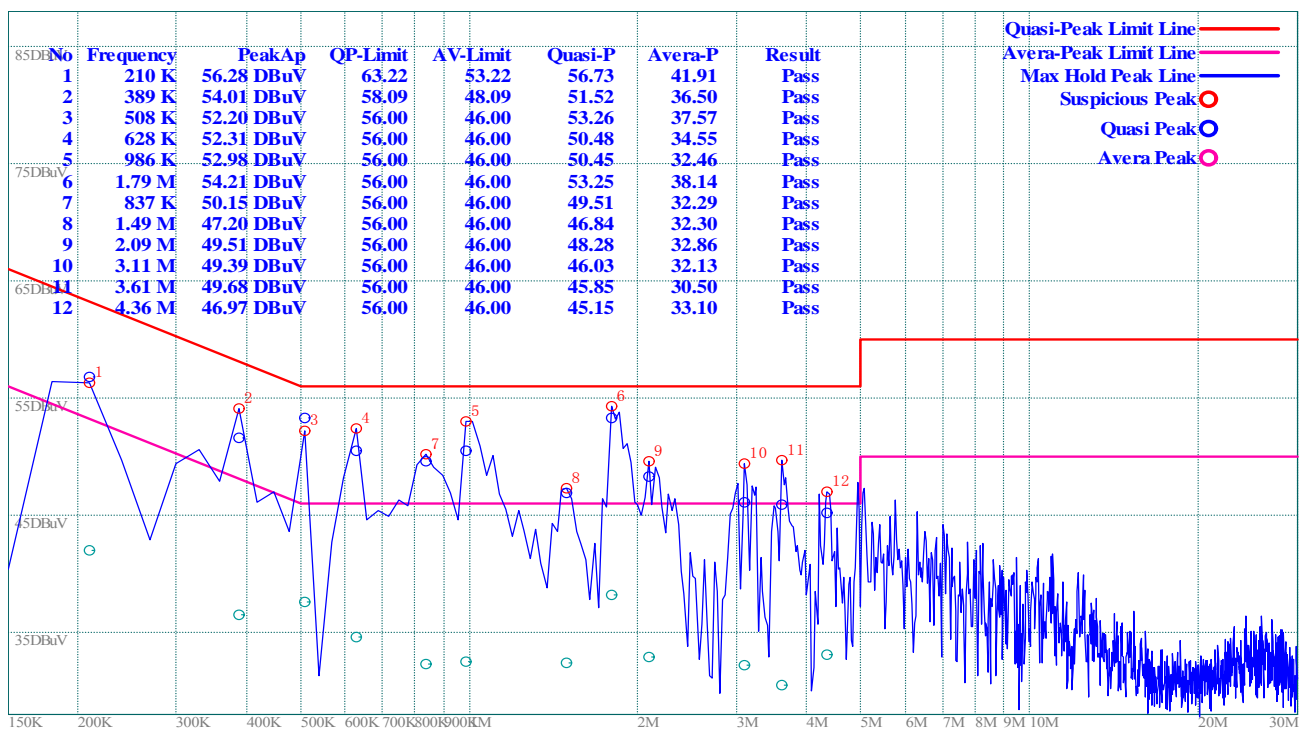
3.2.3 Test Result

(1) Call Mode

A. Test Plot And Suspicious Points



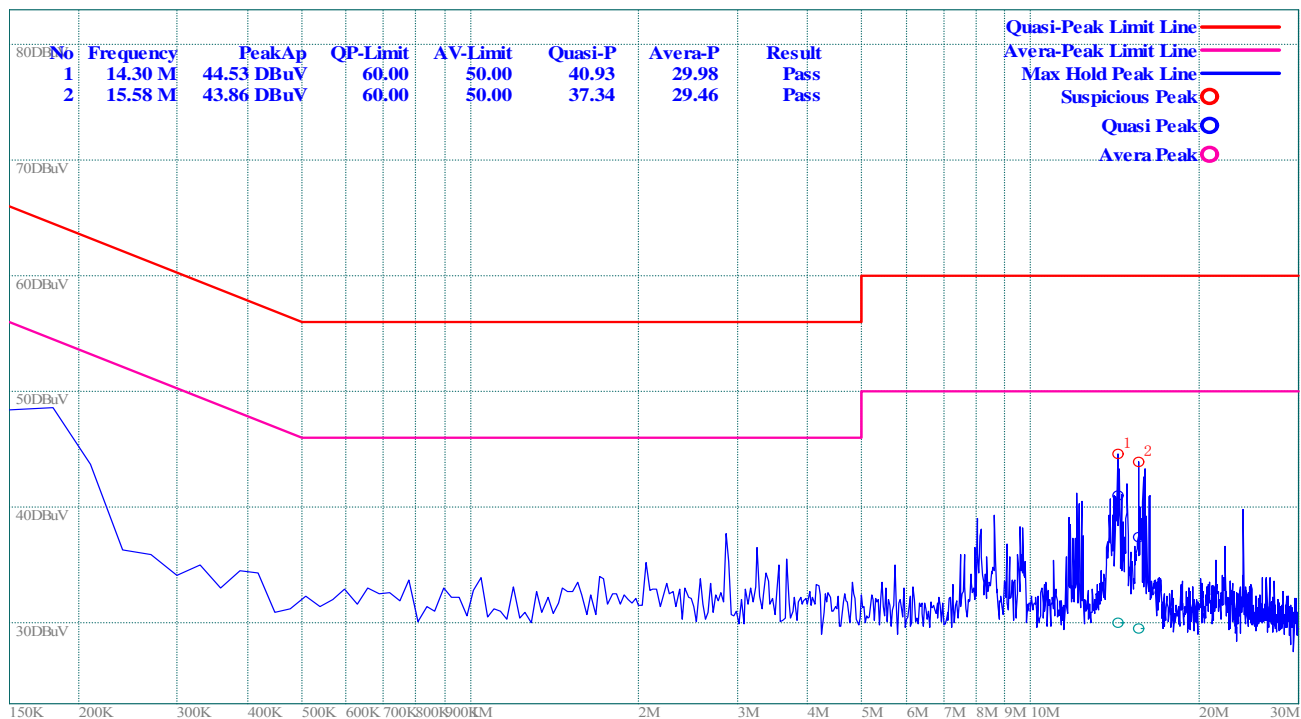
(Plot A: L Phase)



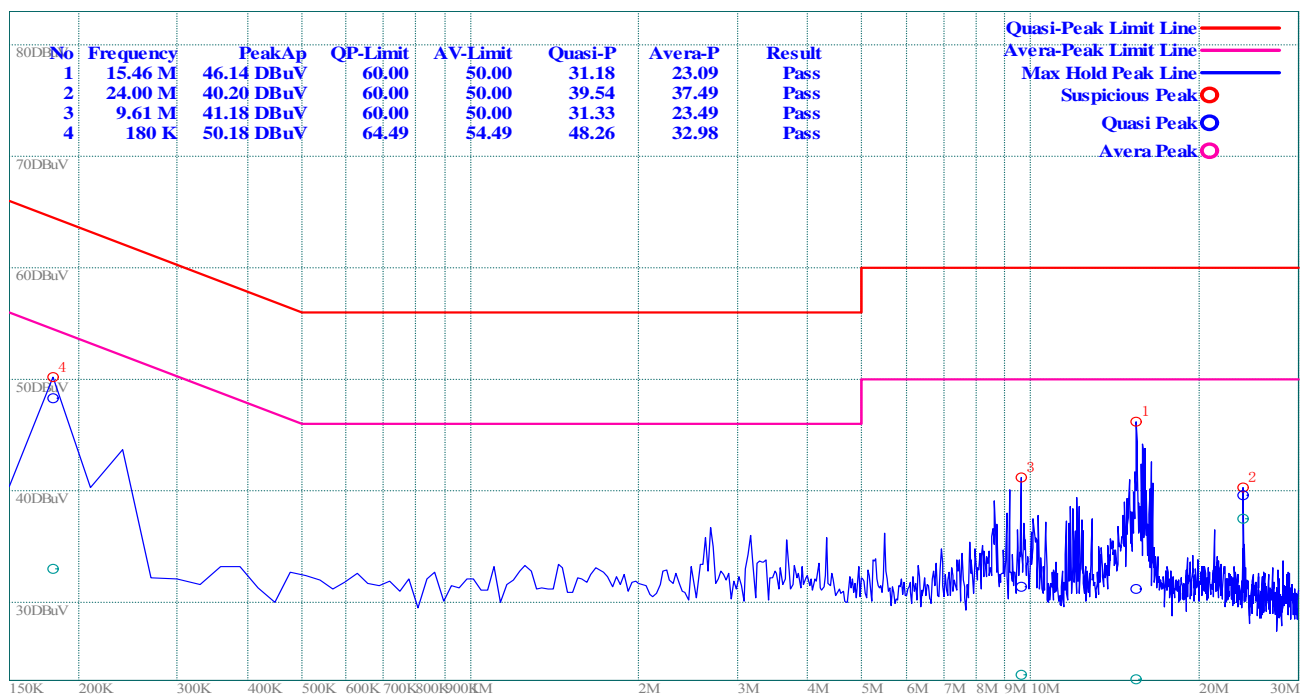
(Plot B: N Phase)

(2)USB Mode

A. Test Plot And Suspicious Points



(Plot A: L Phase)



(Plot A: N Phase)

3.3 Radiated Emission

3.3.1 Requirement

According to FCC §15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength	
	$\mu\text{V/m}$	$\text{dB}\mu\text{V/m}$
30 - 88	100	40
88 - 216	150	43.5
216 - 960	200	46
Above 960	500	54

NOTE:

1. Field Strength ($\text{dB}\mu\text{V/m}$) = $20 \cdot \log[\text{Field Strength } (\mu\text{V/m})]$.
2. In the emission tables above, the tighter limit applies at the band edges.

3.3.2 Test Procedure

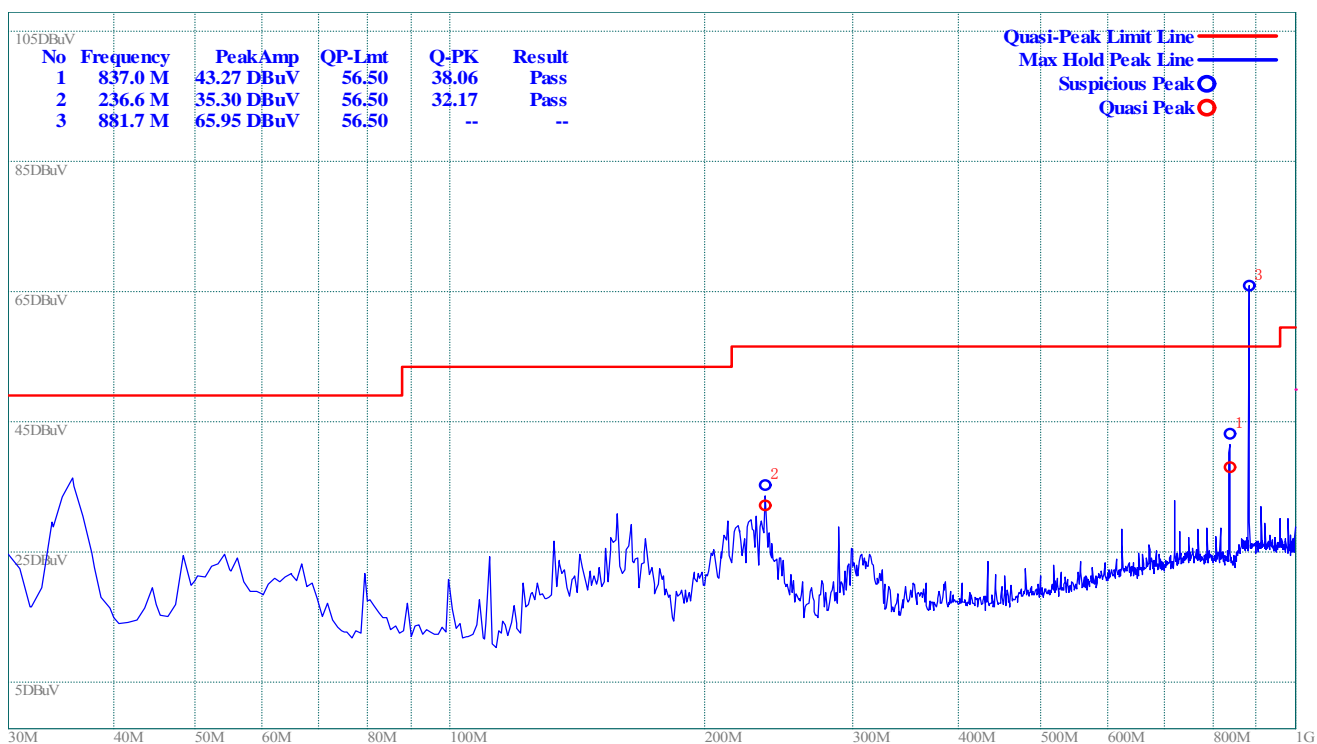
1. Perform test setup as described in section 3.1.2.2.
2. Each test mode in section 3.1.1 should be applied. At each test mode, the Turn Table turns from 0 degrees to 360 degrees to find the maximum reading; for the suspected points, the Test Antenna varies from 1 meter to 4 meters to determine the maximum value of the field strength.
3. The Receiver is set to Peak Detector function and specified bandwidth with maximum hold mode. If the emission level of the EUT in peak mode is 6dB lower than the limit specified, then testing could be stopped and the peak values would be reported; otherwise the emission less than 6dB margins would be retested one by one using the quasi-peak method.
4. The emission levels at both horizontal and vertical polarizations should be tested.
5. Record the test result plot and distinct points.
6. In the test report show the worst test data.

3.3.3 Test Result

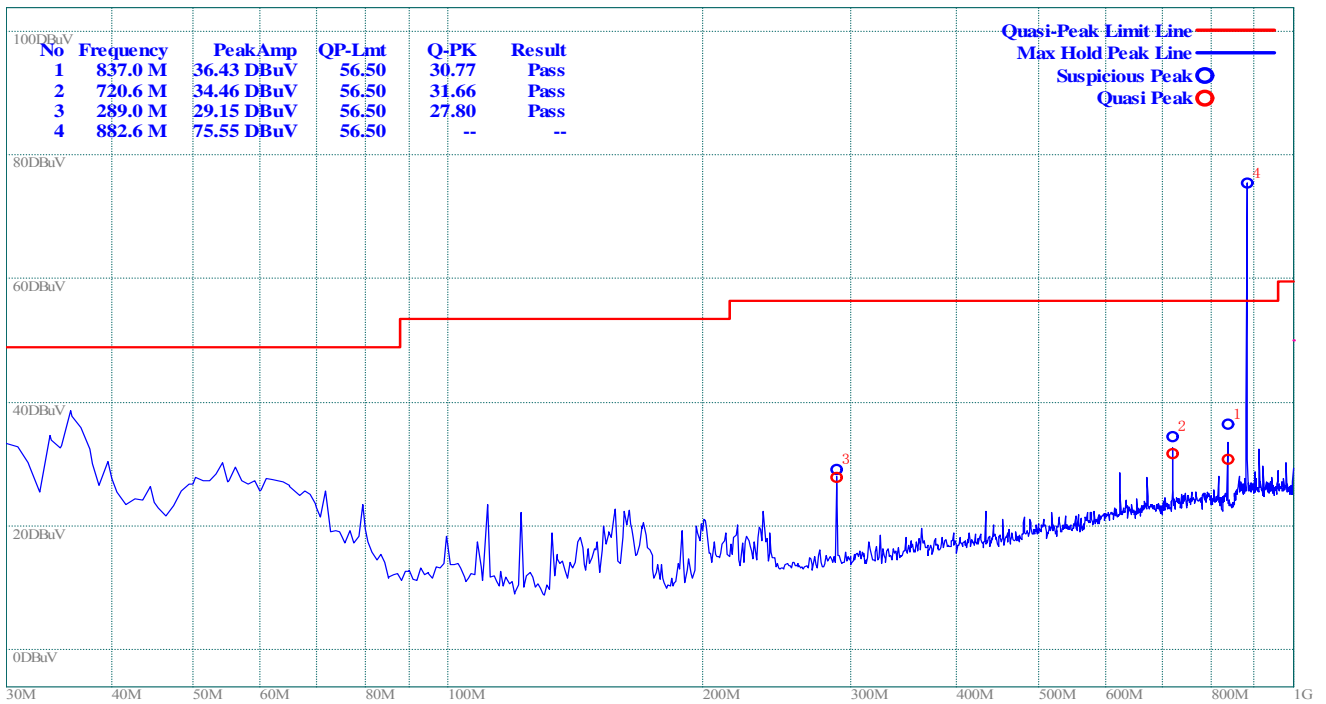
(1) Call Mode

A. Test Plot And Suspicious Points

Note: "--" in the table above means that the emissions are too small to be measured and are at least 10 dB below the limit.



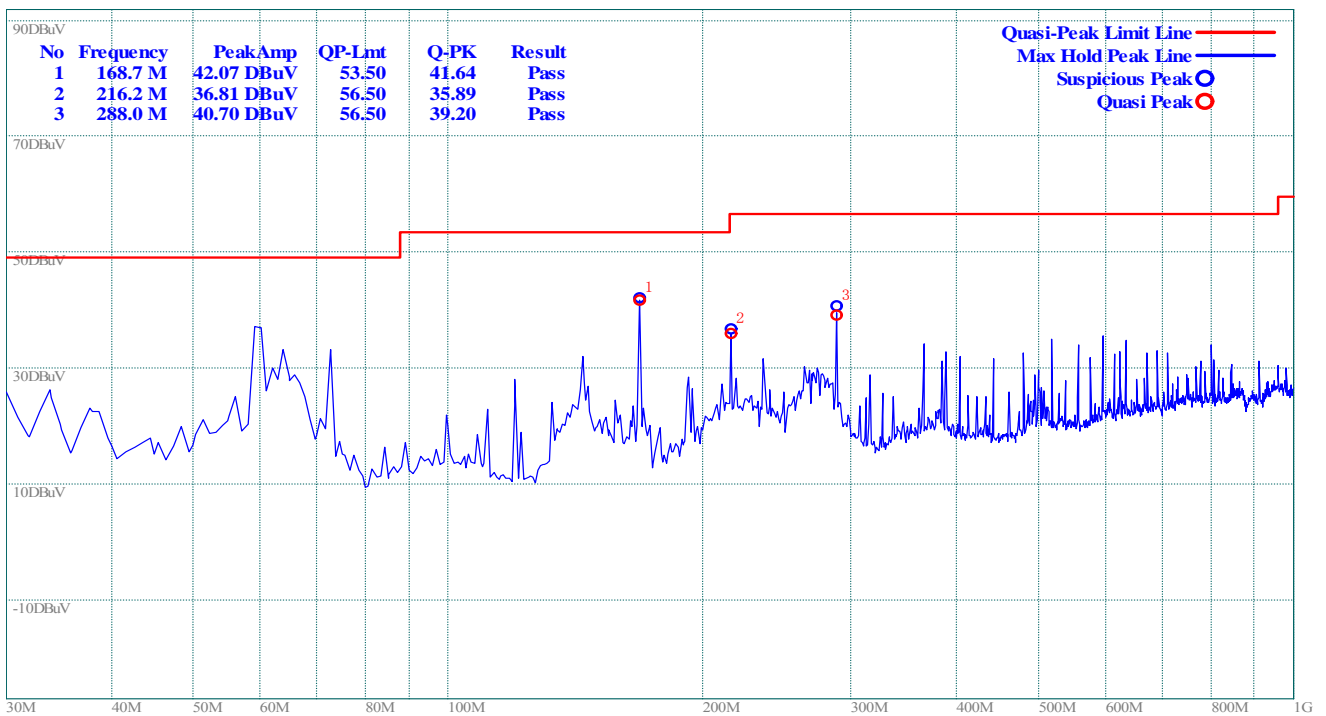
(Plot A: Test Antenna Vertical)



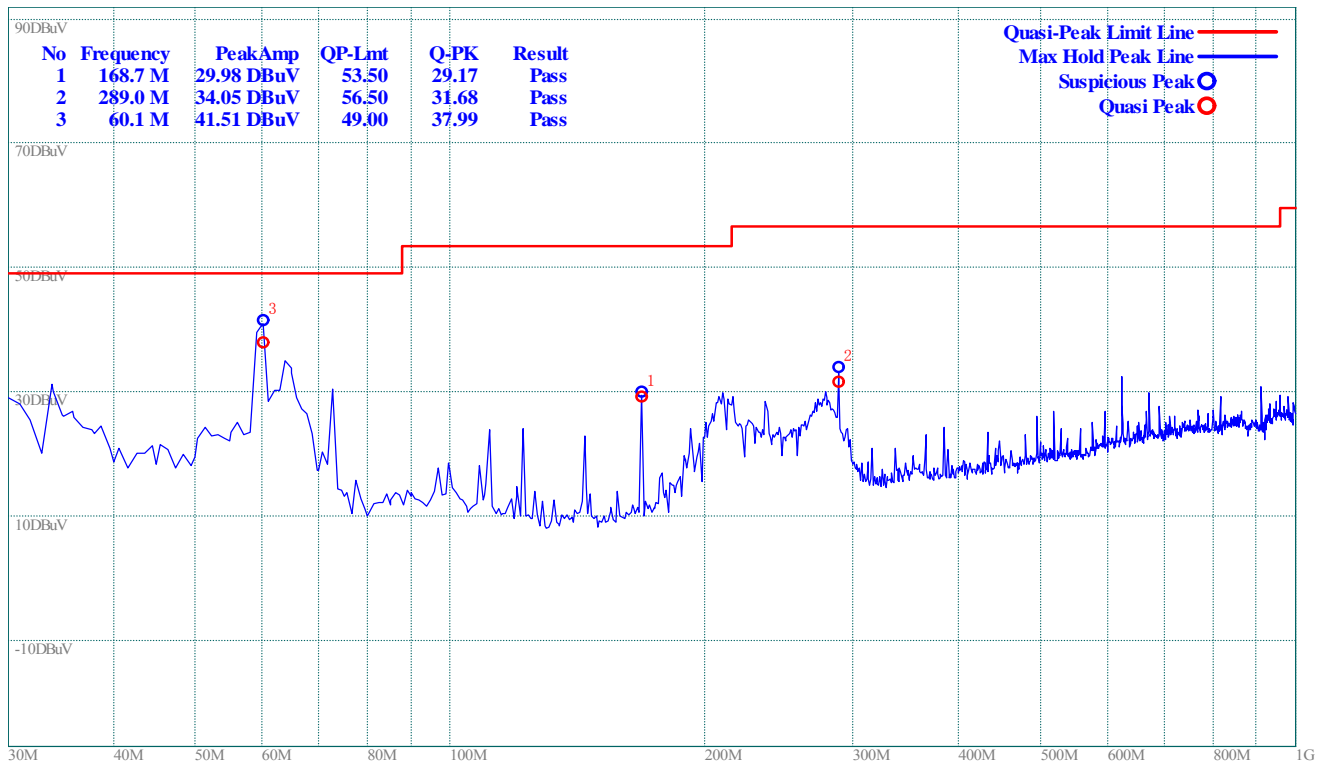
(Plot B: Test Antenna Horizontal)

(2)USB Mode

A. Test Plot And Suspicious Points



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

***** END OF REPORT*****